Notice of References Cited Application/Control No. 09/474,056 Examiner Toan D Nguyen Applicant(s)/Patent Under Reexamination DJUPHAMMAR ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,374,112 B1	04-2002	Widegren et al.	455/452
	В	US-6,418,148 B1	07-2002	Kumar et al.	370/468
	С	US-			
	D	US-			
	Е	US-			
	F	US-		_	
	G	US-			
	Н	US-			
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FOREIGN PATENT DOCUMENTS

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Notice of References Cited Application/Control No. 09/474,056 Examiner Toan D Nguyen Applicant(s)/Patent Under Reexamination DJUPHAMMAR ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,389,008 B1	05-2002	Lupien et al.	370/352
	В	US-6,385,179 B1	05-2002	Malcolm et al.	370/329
	С	US-			
	D	US-			
	Ε	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.